

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/864,376	OHMI ET AL.	
Examiner	Art Unit	
Rudy Zervigon	1763	

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
microwave with ("standing wave" and node and surface)	7/10/2006	RZ
Refer to EAST querries	7/10/2006	RZ
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